

**Search Notes**

Application/Control No.

10/639,462

Examiner

Benny Q. Tieu

Applicant(s)/Patent under  
Reexamination

ASAMI ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	142.01 142.07 142.12 142.15	9/13/2006	BQT
	88.21		
	167.07		
	167.11		
	167.13		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR